

<b>Notice of References Cited</b>	Application/Control No. 10/790,784		Applicant(s)/Patent Under Reexamination MURAKAMI, NAOYA	
	Examiner MARCUS T. RILEY		Art Unit 2625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,550,638 A	08-1996	Ikeda et al.	358/296
*	B	US-5,784,180 A	07-1998	Sakai et al.	358/501
*	C	US-6,434,266 B1	08-2002	Kanno et al.	382/162
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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